


<b>Search Notes</b>  	<b>Application/Control No.</b>  10575899	<b>Applicant(s)/Patent Under Reexamination</b>  WATANABE ET AL.
	<b>Examiner</b>  Long Pham	<b>Art Unit</b>  2814

SEARCHED			
Class	Subclass	Date	Examiner
257	79	10/26/07	LP

SEARCH NOTES		
Search Notes	Date	Examiner
Updated text or interference searches	10/26/07	LP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	79	10/26/07	LP